

# Exhibit 1

**PROFESSIONAL SUMMARY**

Currently a Registered Professional Engineer (#79454) and recognized as an inventor on 25 US and a number of foreign patents, I am President of M<sup>®</sup>Alexander Sound, Inc., and the Managing Director of M<sup>®</sup>Alexander Sound Pte Ltd. I have focused my expertise to support a number of clients in product, process, and operations analysis and investigation. Thirty-six years of experience in microcircuit and semiconductor technologies has developed my skills in areas of circuit design and analysis, device fabrication and assembly, testing, marketing, control system design and analysis, manufacturing operations and respective areas of quality, reliability, and defect / failure analysis. I am a Partner with RMC Management, supporting clients in asset management, and the President and CEO of MDFHoldings, Inc., an IP holding company currently engaged in the field of GPS Tracking. I have:

- designed Dynamic Random Access Memories (DRAMs), Static Random Access Memories (SRAMs), Charge Coupled Devices (CCDs), Shift Registers (SRs), and functional circuits including I/O buffers for address and data, decoders, clocks, sense amplifiers, fault tolerant, parallel-to-serial data paths for video applications, level shifters, converters, pumps, and logic, as well as wireless communication systems and MEMs;
- managed operations including engineering, training, and quality assurance for device fabrication, assembly, test, analysis, and reliability assessment, as well as manufacturing control; testing, analysis, and control involved use of mechanical calibration and measuring equipment, including optical, scanning e-beam, IR, capacitive, and laser using phase contrast and FFT for HAR applications;
- taught courses in solid state device physics, integrated circuit design, integrated circuit fabrication, and statistical control;
- provided expert services, investigating both process and design technologies of various devices (microprocessor and controller, memory, programmable logic, card, tag, module, mixed signal, custom, and other), systems (PC and peripheral, computer, control, laser measurement, switch, architecture, software, and other), and consumer products (medical, TV, telephone, VCR, facsimile, copier, lighting, game, and other); and
- provided nuclear radiation hardness testing services for military and space clients.

From 1986-1990, I was Executive Vice President of EPI Technologies, Inc., prior to joining the staff at Cochran Consulting, Inc. where I served as senior managing consultant from 1991-2002. From 1972 to 1986, I was employed by Texas Instruments Incorporated - two years as the Quality and Reliability Manager for the 256K DRAM wafer fabrication facility, three years as the Engineering/QRA Manager for the TI Singapore test and assembly operation, and nine years in semiconductor design and product engineering management functions.

**EXPERIENCE PROFILE**

- 2005-present      **McAlexander Sound Pte Ltd - Singapore**  
**Managing Director**
- o System, Product, and Process investigation, expert witness services for protection of intellectual property;
  - o Patent portfolio development and valuation;
  - o Contract consultation.
- 2002-present      **MDFHoldings, Inc. – Las Vegas, NV**  
**CEO**
- o IP holding and licensing company.
- 1996-present      **RMC Management, LLP - Plano, TX**  
**Partner**
- o Asset management.
- 1988-present      **McAlexander Sound, Inc. (McASI) - Plano, TX**  
**President**
- o System, Product, and Process investigation, expert witness services for protection of intellectual property;
  - o Patent portfolio development and valuation;
  - o Product liability and insurance claim investigation, expert witness services for matters involving such claims;
  - o Quality Systems consulting and engineering;
  - o Radiation Hardness Testing Technical Representative;
  - o Technical Advisor in High Aspect Ratio and Surface Contour Measurement using Direct-to-Digital Holography.

**EXPERIENCE PROFILE** (continued)

1991-2002      **Cochran Consulting, Inc. (CCI) - Richardson, TX**  
**Managing Consultant**

- o System, Product, and Process investigation, expert witness services for protection of intellectual property;
- o Design, process, and product reliability;
- o Defect and failure analysis.

1986-Nov'90      **EPI Technologies, Inc. - Richardson, TX**  
**Executive Vice President and Company Officer**

- o Managed Advanced Technology Div., QA, and Engineering;
- o Developed strategic, space/energy market growth plans;
- o Negotiated the acquisition of a radiation company;
- o Designed and managed physical analysis, radiation effects, and environmental stress laboratories, including optical and e-beam measurement;
- o Achieved > 30% annual revenue growth and profitability for each laboratory the first 12 months;
- o Product and Process investigation services for protection of intellectual property.

1972 – 1986      **Texas Instruments, Inc. - Dallas/Houston, TX; Singapore**

'84 - '86      **Quality/Reliability Assurance Manager, TI Dallas Advanced DRAM**  
semiconductor wafer fabrication facility

- o Developed/implemented on-line, computerized SPC tools for dimensioning analysis and control and pattern recognition;
- o Coordinated people development, design-of-experiments;
- o Managed chemical and physical analysis laboratories;

**EXPERIENCE PROFILE (continued)**

- o Implemented control systems to assure product, process, material, equipment, and facility compliance, including Cost of Quality analysis.

**'82 - '84      Quality/Reliability Assurance and Engineering Manager, TI Singapore assembly/test facility**

- o Developed, implemented, and operated an effective Quality/Reliability Assurance program for assembly processing including optical pattern recognition for equipment registration;
- o Supervised 225 people for 7 day/week operation, including QRA, Computer Systems, and Training;
- o Trained engineers in Solid State Physics, device fabrication, and statistical process control.

**'81 - '82      Engineering Operations Manager, TI Houston**

- o Managed DRAM memory product cost center;
- o Responsible for division test software generation, product assembly and test quality / yield, cost reduction and quality improvement;
- o Provided technical customer interface for marketing;
- o Coordinated TI Singapore engineering test/assembly.

**'79 - '81      Product Engineering Manager, TI Houston**

- o Responsible for yield improvement, technical customer interface, quality improvement, design evaluation, and device characterization for DRAM and CCD products;
- o Developed device specifications and test software.

**'72 - '79      Design Section Manager / Engineer, TI Houston**

- o Responsible for design and development, process compatibility, production introduction of Dynamic Ram products;

**EXPERIENCE PROFILE** (continued)

- o Activities included electrical and physical layout, SPICE model simulation, test program generation, and product implementation for MOS Dynamic Ram products.

1969 - 1972

**U. S. Army - Coventry, Rhode Island; Seoul, Korea**  
**Captain, Air Defense Artillery**

- o Served one year as Communications Officer in Korea;
- o Served two years as Tactical Officer, New England Defense.

**PROFESSIONAL ORGANIZATIONS AND AWARDS**

- 1 - Institute of Electrical and Electronics Engineers, Inc. (IEEE), Senior Member. Societies: Computer, Electron Devices, Solid State Circuits
- 2 – Licensing Executives Society (LES)
- 3 – National Society of Professional Engineers
- 4 – Texas Board of Professional Engineers, Registered License #79454
- 5 - 2000/2001 Nationwide Register's Who's Who in Executives and Businesses
- 6 - 1996/1997 Strathmore's Who's Who Registry of Business Leaders

**PUBLICATIONS**

- 1- NUS Proceedings of Engineering Convention '83, Aug '83, pgs. 139-142, The Memory Challenge.
- 2- Archives of Biochemistry and Biophysics, Dec'81, Vol. 212, No. 2, Equilibrium Constants under Physiological Conditions for the Reactions of D-3-Phosphoglycerate Dehydrogenase and L-Phosphoserine Aminotransferase.
- 3- International Electron Devices Meeting, Dec '79, pgs. 355-357, Sub 100ns 16K x 1 MOS Dynamic RAM Using a Grounded Substrate.

**EDUCATION PROFILE**

1980 - 1985	Taught Solid State Device Physics, Semiconductor Processing, and Circuit Design Techniques  Taught Statistical Quality Control methods  Effectiveness Training and Japanese Manufacturing Techniques, Participative Problem Solving courses
1975 - 1976	1.5 years Graduate study in Neural Science, the University of Texas Graduate School of Biomedical Science
1965 - 1969	BSEE, North Carolina State University

**PATENTS (US-25 Foreign-5)**

4,239,993	High Performance Dynamic Sense Amplifier with Active Loads
4,280,070	Balanced Input Buffer Circuit for Semiconductor Memory
4,288,706	Noise Immunity in Input Buffer Circuit for Semiconductor Memory
4,370,575	High Performance Dynamic Sense Amplifier with Active Loads
4,418,293	High Performance Dynamic Sense Amplifier with Multiple Column Outputs
4,533,843	High Performance Dynamic Sense Amplifier with Voltage Boost for Row Address Lines
4,543,500	High Performance Dynamic Sense Amplifier Voltage Boost for Row Address Lines
4,543,501	High Performance Dynamic Sense Amplifier with Dual Channel Grounding Transistor
4,748,349	High Performance Dynamic Sense Amplifier with Voltage Boost for Row Address Lines

**PATENTS (continued)**

6,172,640 B1	Pet Locator
6,236,358 B1	Mobile Object Locator
6,421,001 B1	Object Locator
6,441,778 B1	Pet Locator
6,480,147 B2	Portable Position Determining Device
6,518,919 B1	Mobile Object Locator
6,771,213 B2	Object Locator
6,859,171 B2	Mobile Object Locator
7,113,126 B2	Portable Positioning Determining Device
7,179,674 B2	Bi-Directional Released-Beam Sensor
7,209,075 B2	Mobile Object Locator
7,324,044 B2	Object Locator
7,336,227 B2	Portable Position Determining Device
7,340,260 B2	System and Method for Tracking the Location of Multiple Mobile Radio Transceiver Units
7,353,706 B2	Weighted Released-Beam Sensor
7,397,097 B2	Integrated Released Beam Layer Structure Fabricated in Trenches and Manufacturing Method Thereof
JP84044720 B4	Semiconductor High Speed Read/Write Memory Unit
JP88053640 B4	Defect Resistant Semiconductor Memory Cell
DE2935121 C2	Clock Voltage Generator for Semiconductor Memory with Reduced Power Dissipation



**PATENTS (continued)**

DE3043651 A1	Clock Voltage Generator for Semiconductor Memory with Reduced Power Dissipation
GB2032211 B2	High Performance Dynamic MOS Read/Write Memory

**CASES**

Cases, in which I have signed a Protective Order, have testified as an expert either at a trial, hearing, or deposition, or have submitted statements / opinions, are:

<b>CASE</b>	<b>CASE NUMBER</b>	<b>LOCATION</b>	<b>YEAR</b>	<b>TYPE<sup>1</sup></b>
Rambus v. Infineon* <sup>2</sup> (*firm: Kirkland & Ellis)	3-00CV524	Richmond, VA	2000 - 2005	P

(Patents related to RDRAM, synchronous clocks applied against SDRAMs)

*Micron v. Rambus (*firm: Weil Gotshal ..)	00-792-RRM	Wilmington, DE	2000 -	P <sup>3</sup>
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(Patents related to RDRAM, synchronous clocks applied against SDRAMs)

Boss v. Bombardier* (*firm: Morgan & Finnegan)	H-00-3491	Houston, TX	2001 - 2005	P
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(Patents related to safety control system for snow and ski mobiles)

Apex* v. Raritan (*firm: Nixon & Vanderhye)	01-CV-4435 (MP)	New York, NY	2001- 2005	P
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(Patents related to video and data transmission, KVM control and OSD)

T-Netix* v. MCI/Global (*firm: McKool Smith)	2-01 CV 189 DF	Marshall, TX	2002 - 2003	P
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(Patents related to penal institution telephone communication control)

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<sup>1</sup> P = Patent; C = Contract; TS = Trade Secret, AT = Antitrust

<sup>2</sup> \* = Client

<sup>3</sup> = Pending

## Cases (continued)

CASE	CASE NUMBER	LOCATION	YEAR	TYPE
IEX* v. Blue Pumpkin (*firm: McKool Smith)	4:01CV16	Sherman, TX	2002 - 2005	P

(Patents related to penal institution telephone communication control)

Opti v. NSC* (*firm: McDermott Will & Emery)	C02-02106 JF/RS	San Jose, CA	2003	P
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(Patents related to computer bus communication architecture)

Linear Technology v. Micrel* (firm: Sidley Austin Brown & Wood)	C 94-1633 MHP (EDL)	San Francisco, CA	2003 - 2005	P
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(Patent related to integrated transistor drive circuit)

Philips v. CMT* (*firm: Ostrolenk Faber)	02-123 KAJ	Wilmington, DE	2003 - 2004	P
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(Patents related to portable, wireless remote control systems)

Knipp v. Galasso* et al (*firm: Shannon, Gracey...)	153-191270-02	Tarrant County, TX	2003	P
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(Patent Application related to thin film test and characterization equipment)

Dusan* v. Travellers Ins (*firm: Parsons)	CV-S-01-0963	Las Vegas, NV	2003 - 2007	C
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(Insurance liability for damaged shipment)

Sandisk v. Infineon* (*firm: Bartlit Beck...)	C-03-02931 MJJ	ND, CA	2004 - 2007	P
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(Patents related to IC design and architecture)

**Cases (continued)**

<b>CASE</b>	<b>CASE NUMBER</b>	<b>LOCATION</b>	<b>YEAR</b>	<b>TYPE</b>
MoSys* v. Synopsis (*firm: Bingham McCutchen)	397-N	Wilmington, DE	2004	C
(Contract dispute case)				
Lexar* v. Toshiba (*firm: Weil Gotshal...)	CV812458	Santa Clara, CA	2004 - 2005	TS
(Trade Secret violation, missuse of IP)				
Lexar* v. Toshiba (*firm: Weil Gotshal...)	C 03-0167 MJJ	Santa Clara, CA	2004 - 2006	P
(Patents related to semiconductor memory system protocol and architecture)				
Toshiba v. Lexar* (*firm: Weil Gotshal...)	C 02-05273 MJJ	Santa Clara, CA	2004 - 2006	P
(Patents related to semiconductor memory system protocol and architecture)				
Lexar* v. Pretec et al (*firm: Weil Gotshal...)	C 00-4770 MJJ	Santa Clara, CA	2004 - 2007	P
(Patents related to semiconductor memory system protocol and architecture)				
Osram v. Dominant* (*firm: Hogan & Hartson)	337-TA-512	Wash, DC	2004	P
(Patents related to LED devices)				
Infineon* v. Mosaid (*firm: Kirkland & Ellis)	03-CV-4698 (WJM) 02-5772 (JF/RS)	NJ ND CA	2004 - 2005	P
(Patents related to semiconductor memory and memory control)				
STM* v. Broadcom (*firm: Sidley Austin...)	4:02 CV 362	ED, TX	2004	P
(Patents related to IC architecture)				

**Cases (continued)**

<b>CASE</b>	<b>CASE NUMBER</b>	<b>LOCATION</b>	<b>YEAR</b>	<b>TYPE</b>
Mitutoyo* v. Central Purchasing (*firm: Oliff & Berridge)	03_C_0990	Chicago, IL	2004 - 2008	P
(Patents related to electronic calipers)				
Microunity v. Intel* (*firm: Weil Gotshal)	2-04CV120-TJW	Marshall, TX	2004 - 2005	P
(Patents related to microprocessors and memory)				
Avocent* v. ClearCube (*firm: Davidson Berquist...)	5:03-CV-2875	Huntsville, AL	2004 - 2006	P
(Patents related to computer video transmission and reception)				
Mosaid v. Infineon* (*firm: Kirkland & Ellis)	6:05CV120 (LED)	Tyler, TX	2005 - 2006	P
(Patents related to semiconductor memory and memory control)				
Antor* v. Nokia et al (*firm: Fulbright & Jaworski)	2:05-CV-186-DF	Marshall, TX	2005 -	P <sup>3</sup>
(Patent related to download / streaming)				
Alt* v. Medtronic (*firm: Weil Gotshal...)	2 04CV370 LED	Marshall, TX	2005 - 2006	P
(Patents related to pacemakers and defibrillators)				
Micron* v. Tessera (*firm: Jones Day)	2:05-CV-319-LED	ED, TX	2005 - 2006	P
(Patents related to IC packaging)				

## Cases (continued)

CASE	CASE NUMBER	LOCATION	YEAR	TYPE
Rambus v. Samsung* (*firm: Weil Gotshal...)	C 05 02298 WDB	San Jose, CA	2005 -	P <sup>3</sup>
(Patents related to RDRAM, synchronous clocks applied against SDRAMs)				
Rambus v. ... Samsung* (*firm: Weil Gotshal...)	C 05 00334 EDL	San Francisco, CA	2005 -	P <sup>3</sup>
(Patents related to RDRAM, synchronous clocks applied against SDRAMs)				
Samsung* v. Rambus (*firm: Weil Gotshal...)	1454-N	DE Chancery Court	2005 - 2007	C <sup>3</sup>
(Patents related to RDRAM, synchronous clocks applied against SDRAMs)				
Samsung* v. Rambus (*firm: Weil Gotshal...)	3:05cv406	Richmond, VA	2005 - 2007	P
(Patents related to RDRAM, synchronous clocks applied against SDRAMs)				
Toshiba v. Hynix* (*firm: Townsend and Townsend and Crew)	304-CV-2391L 304-CV-2392B	Dallas, TX	2005 - 2007	P
(Patents related to semiconductor memory devices)				
KAI* v. Buck Knives (*firm: Seed Law)	CV-05-0446 HA	Oregon	2005 - 2006	P
(Patents related to knife mechanism)				
FormFactor v. Phicom* (*firm: Mitchell Silberberg...)	05-6062-HO	Oregon	2005 -	P <sup>3</sup>
(Patents related to probe cards)				
Lexar* v. Fuji C (*firm: Weil Gotshal...)	03-00355 MJJ	Santa Clara, CA	2006 - 2007	P
(Patents related to semiconductor memory system protocol and architecture)				

## Cases (continued)

CASE	CASE NUMBER	LOCATION	YEAR	TYPE
Matsushita v. Samsung* (*firm: Akin Gump...)	02-336 (GEB)	New Jersey	2006	P
(Patents related to memory devices)				
Cobra v. BCNY* (*firm: Hogan & Hartson)	05-61225-CIV- MARRA	Ft Lauderdale, FL	2006 -	P <sup>3</sup>
(Patents related to electronic flashing)				
VAC v. T-Netix* (*firm: Bell Nunnally...)	03-11399	Dallas, TX	2006 - 2008	C
(Patents related to communication control systems)				
Actel v. BTR* (*firm: McDermott Will & Emery)	1100046359	Arbitration	2006 - 2007	C
(Patents related to IC architecture)				
Omega* v. Fortin et al (*firm: Allen Dyer...)	6:05-CV-1113- ORL-22-DAB	Orlando, FL	2006 - 2007	P
(Patents related to remote start and security systems)				
Mosaid v. Micron* ... (*firm: Kirkland & Ellis)	2:06-CV-302-DF	ED, TX	2006 - 2009	P <sup>3</sup>
(Patents related to memory devices)				
Mosaid v. ... PowerChip* (*firm: Trop ...)	2:06-CV-302-DF	ED, TX	2006 - 2008	P <sup>3</sup>
(Patents related to memory devices)				
Mosaid v. ...Promos* (*firm: Akin Gump...)	2:06-CV-302-DF	ED, TX	2006 - 2008	P
(Patents related to memory devices)				

**Cases (continued)**

<b>CASE</b>	<b>CASE NUMBER</b>	<b>LOCATION</b>	<b>YEAR</b>	<b>TYPE</b>
Promos* v. Mosaid (*firm: Akin Gump....)	C 06-05788 CS	ND, CA	2006 - 2008	P
(Patents related to memory devices)				
T-Netix* v. VAC (*firm: Bell Nunnally...)	3:05-CV-0654-D	ND, TX	2006 - 2008	P
(Patents related to communication control systems)				
TIP v. ...T-Netix* (*firm: Bell Nunnally...)	H-04-3718	SD, TX	2006 - 2007	P
(Patents related to telephone control systems)				
T-Netix* v. Global et al (*firm: Gruber Hurst...)	2-06cv-426-TJW	ND, TX	2006 - 2008	P
(Patents related to communication control systems)				
Nike* v. adidas (*firm: McDermott Will & Emery)	9:06-CV-43	ED, TX	2006 - 2007	P
(Patents related to measurement of movement)				
PhatRat v. NIKE* (*firm: Banner & Witcoff)	1220035678	Arbitration	2007	P
(Patents related to measurement of movement)				
Comverse* v. ATI (*firm: Dickstein Shapiro)	50 494 T 00319 06	Arbitration	2007 - 2008	C <sup>3</sup>
(Messaging control systems)				



## Cases (continued)

CASE	CASE NUMBER	LOCATION	YEAR	TYPE
ProBatter* v. Joyner (*firm: Hiscock & Barclay)	6:05-cv-02045	Arbitration	2007	P
(Baseball Video Sync)				
TIP v. SBC* (*firm: Bell Nunnally)	4:06-cv-00253	Houston, TX	2007 - 2008	P <sup>3</sup>
(Patents related to telephone control systems)				
Avocent* v. Rose et al (*firm: Davidson Berquist)	C06-1711-MJP	Seattle, WA	2007 -	P <sup>3</sup>
(Patents related to video and data transmission, KVM control and OSD)				
Samsung* v. Matsushita (*firm: Kirkland & Ellis)	6:07-CV-08 (LED)	Tyler, TX	2007 - 2008	P
(Patents related to IC process and design)				
MediaTek* v. Matsushita (*firm: Quinn Emanuel)	6:07-CV-08 (LED)	Marshall, TX	2007	P
(Patents related to PLL)				
Accton v. Centillium* (*firm: Farella Braun)	RG05245726	Alameda Cty, CA	2007	C
(Breach of contract)				
Fenner* v. Microsoft et al (*firm: Fulbright & Jaworski)	6:07-CV-08 (LED)	Tyler, TX	2007 -	P <sup>3</sup>
(Patent related to joystick interface to low voltage port)				

## Cases (continued)

CASE	CASE NUMBER	LOCATION	YEAR	TYPE
Freescall v. ProMOS* (*firm: Hogan & Hartson)	4:06-CV-491 (RAS)	Sherman, TX	2007 - 2008	P <sup>3</sup>
(Patents related to memory access and bus termination)				
Renasas v. Samsung* (*firm: Fish & Richardson)	07-54 (JJF)	DE	2007 - 2008	P
(Patent related to bus termination)				
Renasas v. Samsung* (*firm: Fish & Richardson)	337-TA	ITC	2007	P
(Patent related to bus termination)				
Symbol v. MetroLogic* (*firm: McDermott Will & Emery)	2:05-CV-509 (LED)	ED, TX	2007 - 2008	P
(Patents related to bar code)				
Agere v. Samsung* (*firm: Quinn Emanuel)	2-06-CV-185 (TJW-CE)	ED, TX	2007 -	P <sup>3</sup>
(Patent License Dispute)				
Trontech* v. VTech (*firm: Wong Cabello)	6:06-CV-451-LED	ED, TX (Tyler)	2008 -	P <sup>3</sup>
(Patents related to telephones)				
DESA* v. EML (*firm: Fitch Even)	8-04-0160	MD TN, Nashville	2008 -	P <sup>3</sup>
(Patent related to lighting)				

## Cases (continued)

CASE	CASE NUMBER	LOCATION	YEAR	TYPE
Gemini v. LANDesk* (*firm: Davidson Berquist)	4:07-CV-00521	ND TX, Sherman	2008 -	P <sup>3</sup>
(Patent related to Networks)				
DCS* v. McData (*firm: Haynes Boone)	3:06-CV-812-L	ND TX, Dallas	2008 -	C <sup>3</sup>
(Breech of Contract)				
Bennett Marine v. Lenco* (*firm: Malen Haley)	04-cv-60326-KAM	SD FL, Ft Laud.	2008 -	P <sup>3</sup>
(Patent related to Automated Boat Trim Retraction)				
Samsung* v. ON Semi (*firm: Kirkland & Ellis)	07-449 (JJF)	DE	2008 -	P <sup>3</sup>
(Patents related to circuits and process)				
Orica* v. Austin Powder (*firm: Mcdermott Will & Emery)	CV-07-3337-AHM	CD CA,	2008 -	P <sup>3</sup>
(Patents related to blasting electronic controls)				
FormFactor v. Phicom* (*firm: Finnegan, Henderson, F G & D)	337-TA-621	ITC	2008 -	P <sup>3</sup>
(Patents related to probe cards)				
AMS* v. Crane & Seaga (*firm: Davidson Berquist)-	3:08-CV-0097-JPB	ND WVA, M..burg	2008 -	P <sup>3</sup>
(Patents related to vending machines)				

## Cases (continued)

CASE	CASE NUMBER	LOCATION	YEAR	TYPE
Myriad v. Alltech, Inc.* (*firm: Duane Morris)	1:08-CV-00253-SS	WD TX, Austin	2008 -	TS <sup>3</sup>
(Trade Secret & © related to software)				
SciCo v. Boston Scientific (*firm: Jeffer Mangel)	9:07-CV-00076-RHC	ED TX, Lufkin	2008 -	P <sup>3</sup>
(Patent related to catheters)				
Renishaw* v. TESA (*firm: Oliff & Berridge)		ND IL, Eastern Div	2008 -	P <sup>3</sup>
(Patents related to mfg probes)				
Samsung* v. Sandisk (*firm: Quinn Emanuel)			2008 -	P <sup>3</sup>
(Patents related to integrated circuit devices)				
Rambus v. Micron* (*firm: Quinn Emanuel)	04-431105	SCCA, San Fran	2008 -	AT <sup>3</sup>
(Antitrust claims)				
Harris* v. FedEx (*firm: Allen Dyer)	6:07-CV-1819-Orl- 28KRS	MD FL, Orlando	2008 -	P <sup>3</sup>
(Patents related to ground based wireless communication)				
Omega* v. Lear (*firm: Allen Dyer)	6:07-CV-1422-Orl- 31DAB	MD FL, Orlando	2008 -	P <sup>3</sup>
(Patents related to vehicle alert and remote start)				
Arbitron* v. Int'l Demographics (*firm: Dickstein Shapiro)	2;06-cv-434(TJW)	ED TX, Marshall	2008 -	P <sup>3</sup>
(Patents related to measuring program audiences)				

## Cases (continued)

CASE	CASE NUMBER	LOCATION	YEAR	TYPE
LSI-Agere v. NSC* (*firm: Weil Gotshal)	337-TA-648	ITC	2008 -	P <sup>3</sup>
(Patents related to IC process and structure)				
Affinity Labs* v. BMW (*firm: Duane Morris)	9:08-CV-00164	ED TX, Lufkin	2008 -	P <sup>3</sup>
(Patents related to portable audio player)				
Affinity Labs* v. Dice (*firm: Duane Morris)	9:08-CV-00163	ED TX, Lufkin	2008 -	P <sup>3</sup>
(Patents related to portable audio player)				
Affinity Labs* v. Alpine (*firm: Duane Morris)	9:08-CV-00171	ED TX, Lufkin	2008 -	P <sup>3</sup>
(Patents related to portable audio player)				
Fast Memory Erase v. Spansion* (*firm: Morrison Foerster)	3:08-CV-0977-M	ED TX,	2008 -	P <sup>3</sup>
(Patents related to memory source erase)				

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**Cases (continued)**

<b>CASE</b>	<b>CASE NUMBER</b>	<b>LOCATION</b>	<b>YEAR</b>	<b>TYPE</b>
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